

MOSFET - Power, Single N-Channel 60 V, 21 mΩ, 25 A

NVLJWS022N06CL

Features

- Small Footprint for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	60	V
Gate-to-Source Voltage			V_{GS}	±20	٧
Continuous Drain	Steady State	T _C = 25°C	I _D	25	Α
Current R _{θJC} (Notes 1, 3)		T _C = 100°C		18	
Power Dissipation		T _C = 25°C	P_{D}	28	W
R _{θJC} (Note 1)		T _C = 100°C		14	
Continuous Drain		T _A = 25°C	I _D	7.2	Α
Current R _{0JA} (Notes 1, 2, 3)	Steady	T _A = 100°C		5.1	
Power Dissipation	State	T _A = 25°C	P_{D}	2.4	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.2	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	90	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			IS	24	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 1.1 A)			E _{AS}	42	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

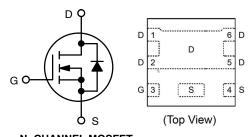
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	5.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	63	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

1

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
60 V	21 mΩ @ 10 V	25 A	
	29 mΩ @ 4.5 V	238	

ELECTRICAL CONNECTION



N-CHANNEL MOSFET



WDFNW6 (2.05x2.05) CASE 515AD

MARKING DIAGRAM



XXXX = Specific Device Code

A = Assembly Location L = Wafer Lot

Y = Year W = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	V _{GS} = 0 V, T _J = 25 °C			10	
		V _{DS} = 60 V	T _J = 125°C			100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	iS = 20 V			100	nA
ON CHARACTERISTICS (Note 4)	<u> </u>						-
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 16 \mu A$		1.2		2.0	٧
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 8 A		17	21	
		V _{GS} = 4.5 V	I _D = 8 A		23	29	mΩ
Forward Transconductance	9FS	V _{DS} =6 V, I _E	_O = 8 A		22		S
CHARGES AND CAPACITANCES					•	•	•
Input Capacitance	C _{ISS}				440		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	łz, V _{DS} = 25 V		240		pF
Reverse Transfer Capacitance	C _{RSS}				7		1 '
Total Gate Charge	$Q_{G(TOT)}$	V _{GS} = 4.5 V, V _{DS} = 48 V; I _D = 8 A			3.6		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V; I _D = 8 A			7.6		nC
Threshold Gate Charge	$Q_{G(TH)}$	V _{GS} = 10 V, V _{DS} = 48 V; I _D = 8 A			0.8		
Gate-to-Source Charge	Q_GS				1.6		nC
Gate-to-Drain Charge	Q_GD				0.9		1
Plateau Voltage	V_{GP}				2.9		V
SWITCHING CHARACTERISTICS (Note	: 5)					•	•
Turn-On Delay Time	t _{d(ON)}				6.0		
Rise Time	t _r	Vos = 10 V. Vr	ne = 48 V.		1.9		1 !
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 10 V, V_{DS} = 48 V, I_D = 8 A, R_G = 6 Ω			15		ns
Fall Time	t _f				2.1		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V},$ $I_S = 8 \text{ A}$	T _J = 25°C		0.85	1.2	
			T _J = 125°C		0.73		\ \
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 8 \text{ A}$			23		
Charge Time	t _a				12		ns
Discharge Time	t _b				11		1
Reverse Recovery Charge	Q _{RR}				12		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

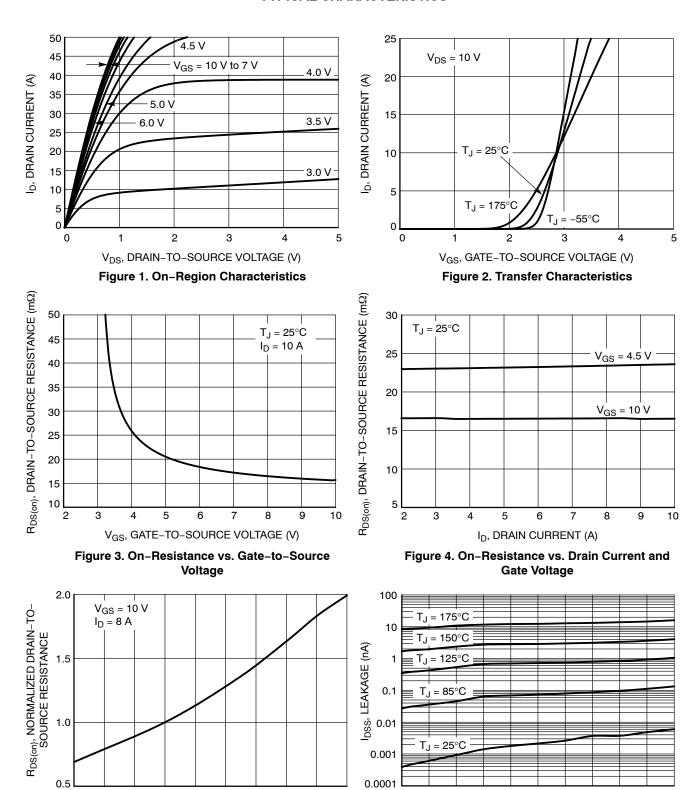


Figure 5. On–Resistance Variation with Temperature

T_J, JUNCTION TEMPERATURE (°C)

50

75

100

125

150

175

25

-25

-50

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 6. Drain-to-Source Leakage Current
vs. Voltage

40

50 55

45

15 20

10

25

30 35

TYPICAL CHARACTERISTICS

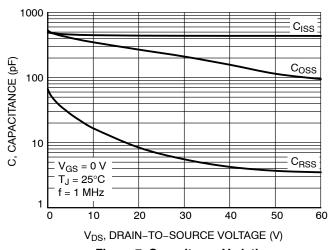


Figure 7. Capacitance Variation

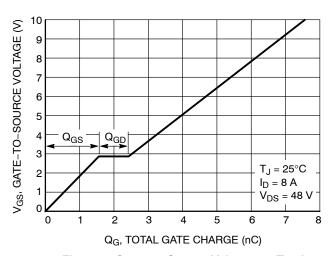


Figure 8. Gate-to-Source Voltage vs. Total Charge

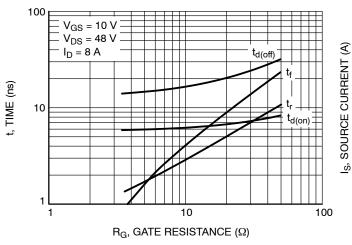


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

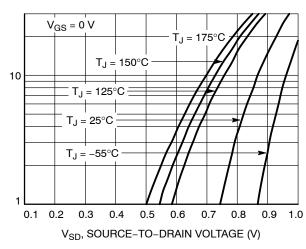


Figure 10. Diode Forward Voltage vs. Current

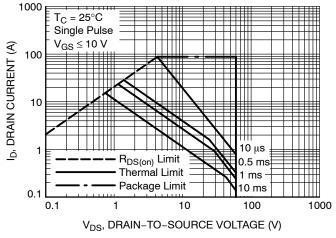


Figure 11. Maximum Rated Forward Biased Safe Operating Area

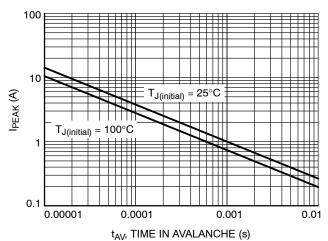


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

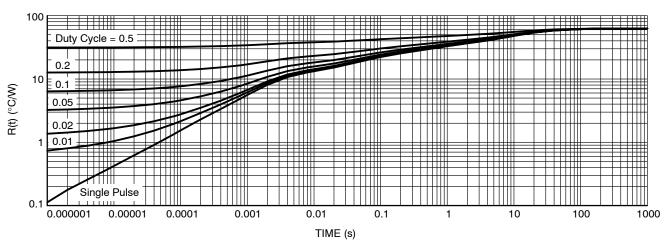


Figure 13. Transient Thermal Impedance

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVLJWS022N06CLTAG	022N	WDFNW6 (Pb-Free, Wettable Flanks)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



PIN ONE

REFERENCE

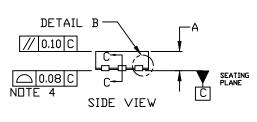
WDFNW6 2.05x2.05, 0.65P

CASE 515AD ISSUE O

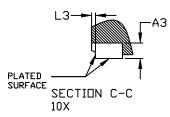
DATE 25 JUN 2021

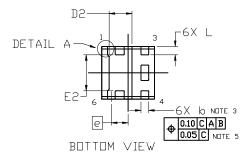


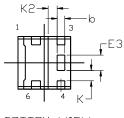
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1. 2009.
- CONTROLLING DIMENSION: MILLIMETERS
 DIMENSION & APPLIES TO PLATED TERMINALS AND IS
 MEASURED BETWEEN 0.15 AND 0.30MM FROM THE TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- POSITIONAL TOLERANCE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.



TOP VIEW

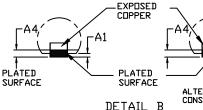


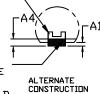




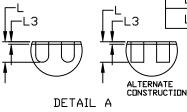
BOTTOM VIEW (SUPPLEMENTAL)

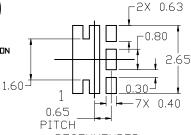
	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	0.70	0.75	0.80	
A1	0.00		0.05	
A3	(0.20 REF	-	
Α4	0.10			
b	0.25	0.30	0.35	
D	1.95	2.05	2.15	
D2	0.84	0.89	0.94	
Е	1.95	2.05	2.15	
E2	1.35	1.40	1,45	
E3	0.55	0.60 0.65		
е	0.65 BSC			
K	0.40 REF			
К2	0.35 REF			
L	0,275	0.325	0.375	
L3			0.09	





В





RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SILLDERRHYD. *This information is generic. Please refer to

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

= Assembly Location

= Wafer Lot L Υ = Year

W = Work Week device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:

WDFNW6 2.05x2.05, 0.65P

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